V.H.F. POWER TRANSISTOR

N-P-N silicon planar epitaxial transistor primarily intended for use in base stations in the v.h.f. mobile radio band.

Features:

- multi-base structure and diffused emitter ballasting resistors for an optimum temperature profile;
- gold metallization ensures excellent reliability.

The transistor has a 1/2 in. 4-lead flange envelope with a ceramic cap. All leads are isolated from the flange.

QUICK REFERENCE DATA

R.F. performance at T_h = 25 °C in a common-emitter class-B circuit

mode of operation	V_{CE} V	f MHz	P_L W	P_S W	G_p dB	η %
narrow band; c.w.	28	175	80	< 17,9	> 6,5	> 70

MECHANICAL DATA

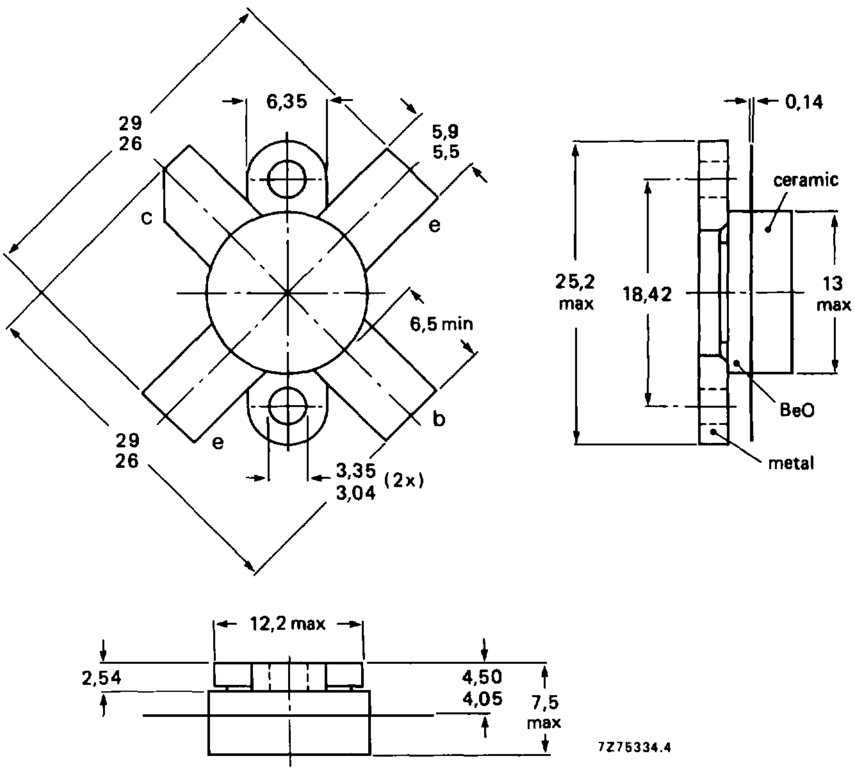
SOT-121 (see Fig. 1)

PRODUCT SAFETY This device incorporates beryllium oxide, the dust of which is toxic. The device is entirely safe provided that the BeO disc is not damaged.

MECHANICAL DATA

Dimensions in mm

Fig. 1 SOT-121.



Torque on screw: min. 0,60 Nm (6,0 kg cm)
max. 0,75 Nm (7,5 kg cm)

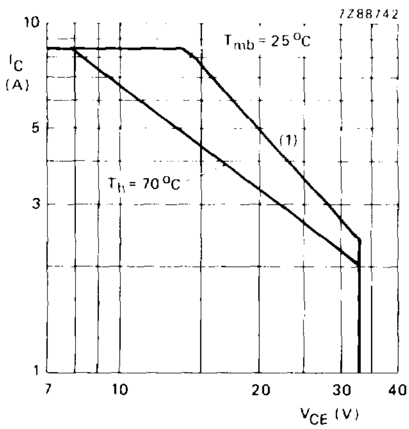
Recommended screw: cheese-head 4-40 UNC/2A

Heatsink compound must be applied sparingly and evenly distributed.

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Collector-emitter voltage (peak-value);				
$V_{BE} = 0$	V_{CESM}	max.	65	V
open base	V_{CEO}	max.	33	V
Emitter-base voltage (open collector)	V_{EBO}	max.	4	V
Collector current				
d.c. or average	I_C; $I_{C(AV)}$	max.	8,5	A
(peak value); f > 1 MHz	I_{CM}	max.	17,5	A
Total power dissipation at T_{mb} = 25 °C	P_{tot}	max.	116	W
R.F. power dissipation				
f > 1 MHz; T_{mb} = 25 °C	P_{rf}	max.	144	W
f > 1 MHz; T_h = 70 °C	P_{rf}	max.	80	W
Storage temperature	T_{stg}	−65 to +150		°C
Operating junction temperature	T_j	max.	200	°C



(1) Second breakdown limit.

Fig. 2 D.C. SOAR.

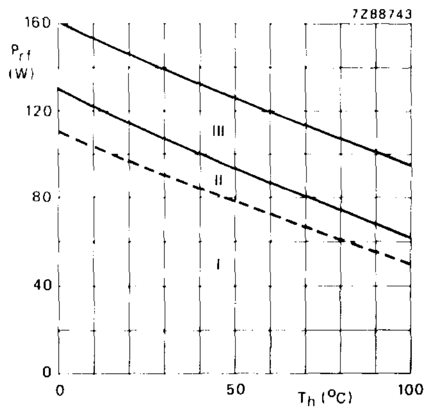


Fig. 3 Power derating curve vs. temperature.

I Continuous d.c. operation
II Continuous r.f. operation; (f > 1 MHz)
III Short-time operation during mismatch; (f > 1 MHz)

THERMAL RESISTANCE (dissipation = 90 W; T_{mb} = 60 °C, i.e. T_h = 33 °C)

From junction to mounting base (d.c. dissipation)	$R_{th\ j\text{-}mb(dc)}$	=	1,50	K/W
From junction to mounting base (r.f. dissipation)	$R_{th\ j\text{-}mb(rf)}$	=	1,30	K/W
From mounting base to heatsink	$R_{th\ mb\text{-}h}$	=	0,3	K/W

CHARACTERISTICS

T_j = 25 °C

Collector-emitter breakdown voltage			
V_{BE} = 0; I_C = 25 mA	$V_{(BR)CES}$	>	65 V
open base; I_C = 100 mA	$V_{(BR)CEO}$	>	33 V
Emitter-base breakdown voltage			
open collector; I_E = 10 mA	$V_{(BR)EBO}$	>	4 V
Collector cut-off current			
V_{BE} = 0; V_{CE} = 33 V	I_{CES}	<	10 mA
Second breakdown energy; L = 25 mH; f = 50 Hz			
open base	E_{SBO}	>	10 mJ
R_{BE} = 10 Ω	E_{SBR}	>	10 mJ
D.C. current gain*			
I_C = 3,5 A; V_{CE} = 25 V	h_{FE}	typ.	45
			15 to 100
Collector-emitter saturation voltage*			
I_C = 10 A; I_B = 2 A	V_{CEsat}	typ.	1,6 V
Transition frequency at f = 100 MHz*			
$-I_E$ = 3,5 A; V_{CB} = 25 V	f_T	typ.	575 MHz
$-I_E$ = 10 A; V_{CB} = 25 V	f_T	typ.	600 MHz
Collector capacitance at f = 1 MHz			
I_E = I_e = 0; V_{CB} = 25 V	C_c	typ.	155 pF
Feedback capacitance at f = 1 MHz			
I_C = 50 mA; V_{CE} = 25 V	C_{re}	typ.	88 pF
Collector-flange capacitance	C_{cf}	typ.	4,5 pF

* Measured under pulse conditions: $t_p > 300\ \mu s$; $\delta < 0{,}02$.

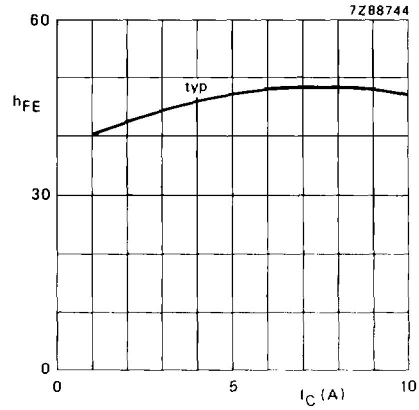


Fig. 4 V_{CE} = 25 V; T_j = 25 ^oC.

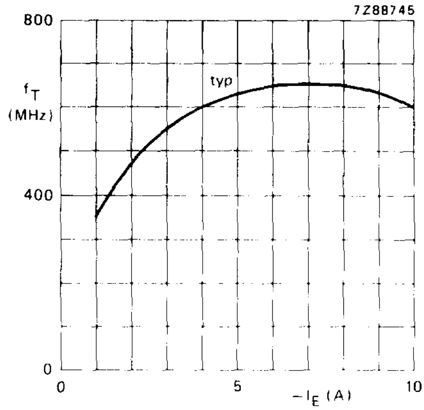


Fig. 5 V_{CB} = 25 V; f = 100 MHz; T_j = 25^oC.

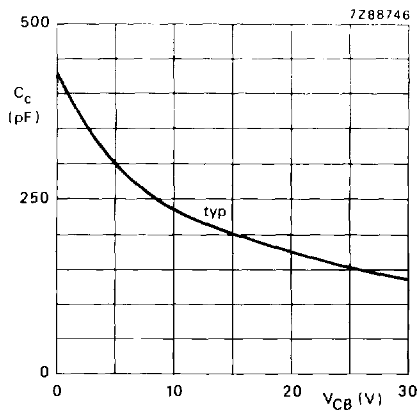


Fig. 6 I_E = I_e = 0; f = 1 MHz; T_j = 25 ^oC.

APPLICATION INFORMATION

R.F. performance in c.w. operation (common-emitter class-B circuit)
f = 175 MHz; T_h = 25 °C

mode of operation	V_{CE} V	P_L W	P_S W	G_P dB	I_C A	η %
narrow band; c.w.	28	80	< 17,9 typ. 16,0	> 6,5 typ. 7,0	< 4,1 typ. 3,8	> 70 typ. 75

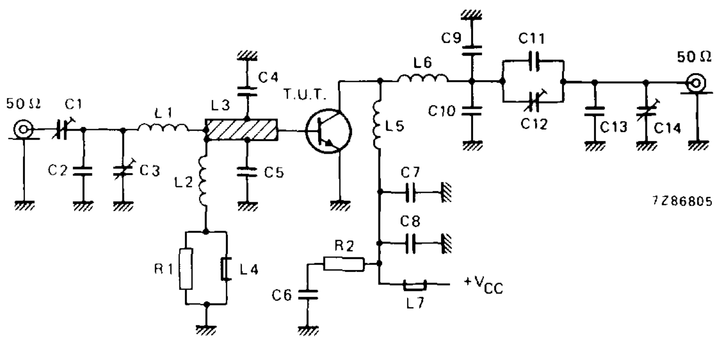


Fig. 7 Class-B test circuit at f = 175 MHz.

List of components:

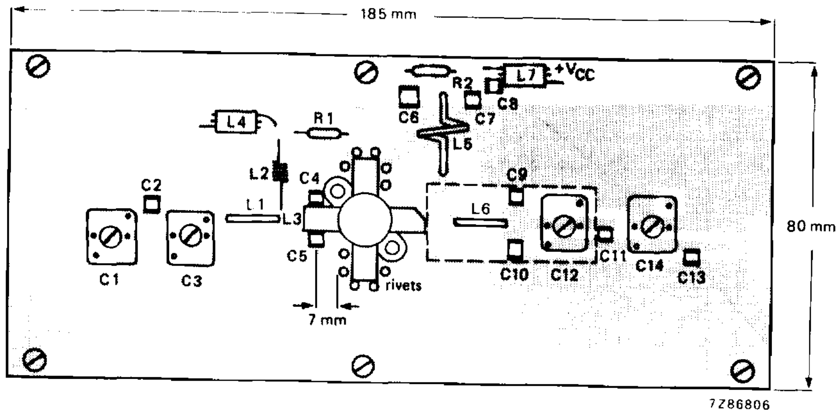
C1 = C12 = C14 = 4 to 40 pF film dielectric trimmer (cat. no. 2222 809 07008)
C2 = 30 pF (500 V) multilayer ceramic chip capacitor*
C3 = 5 to 60 pF film dielectric trimmer (cat. no. 2222 809 07011)
C4 = C5 = 56 pF (500 V) multilayer ceramic chip capacitor*
C6 = 100 nF (50 V) multilayer ceramic chip capacitor
C7 = C8 = 220 pF (50 V) multilayer ceramic chip capacitor
C9 = C10 = 10 pF (500 V) multilayer ceramic chip capacitor*
C11 = 24 pF (500 V) multilayer ceramic chip capacitor*
C13 = 13 pF (500 V) multilayer ceramic chip capacitor*

L1 = Cu wire (1,8 mm); length 15 mm
L2 = 100 nH; 7 turns closely wound enamelled Cu wire (0,5 mm); int. dia. 3 mm; leads 2 x 7 mm
L3 = strip (15 mm x 8 mm); taps for C4 and C5 at 7 mm from transistor edge
L4 = L7 = Ferroxcube wide-band h.f. choke, grade 3B (cat. no. 4312 020 36640)
L5 = 1 turn Cu wire (1,8 mm); int. dia. 9 mm; leads 2 x 10 mm
L6 = 1/2 turn Cu wire (1,8 mm); int. dia. 13 mm; leads 2 x 5 mm

L3 is a strip on a double Cu-clad printed-circuit board with epoxy fibre-glass dielectric, thickness 1/16 in.

R1 = R2 = 10 Ω (± 10%) carbon resistor (0,25 W)

* American Technical Ceramics capacitors or capacitors of same quality.



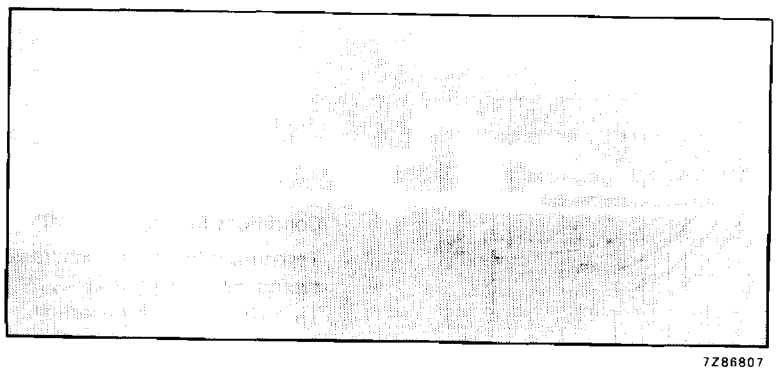


Fig. 8 Component layout and printed-circuit board for 175 MHz.

The circuit and the components are on one side of the epoxy fibre-glass board, the other side is unetched copper to serve as ground-plane. Earth connections are made by hollow rivets and additionally by fixing screws and copper straps at the input and output to provide direct contact between the copper on the component side and the ground-plane.

To minimize the dielectric losses, the ground-plane under the interconnections of L6, C9, C10, C11 and C12 has been removed.

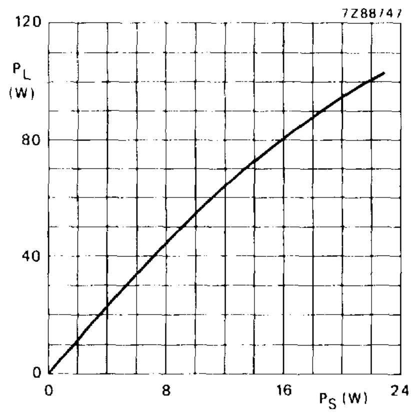


Fig. 9 Load power as a function of source power.

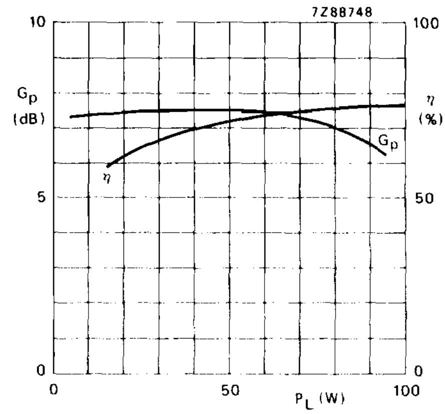


Fig. 10 Power gain and efficiency as a function of load power.

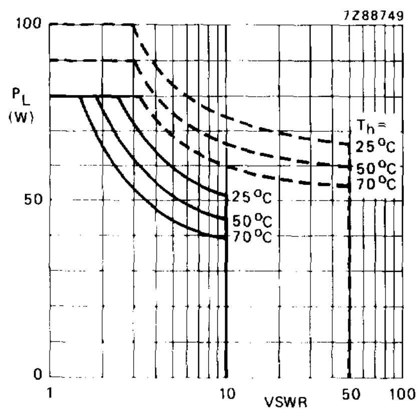


Fig. 11 R.F. SOAR at V_{CE} = 28 V.
—— $f > 1$ MHz (continuous);
- - - - short time operation during mismatch ($f > 1$ MHz).

Conditions for Figs 9 and 10:

Test circuit tuned for each power level; typical values; V_{CE} = 28 V; f = 175 MHz; T_h = 25 °C; class-B operation.

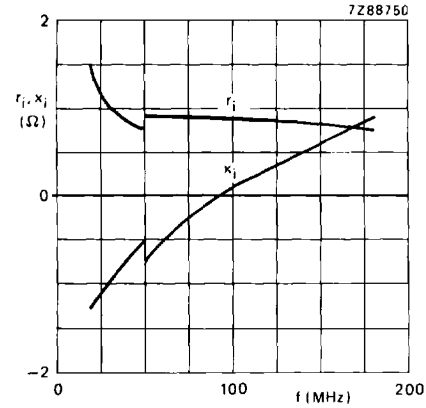


Fig. 12 Input impedance (series components).

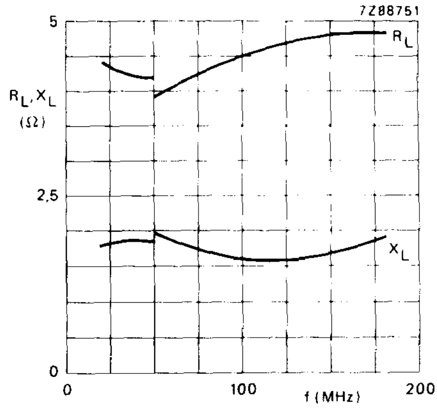


Fig. 13 Load impedance (series components).

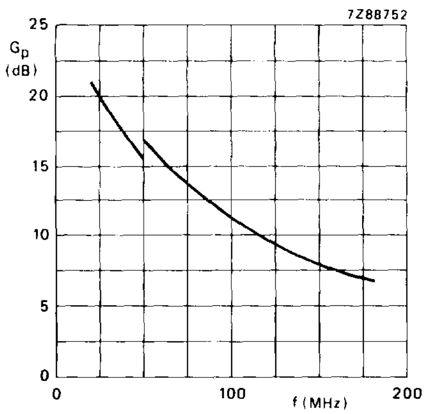


Fig. 14 Power gain as a function of frequency.

Conditions for Figs 12, 13 and 14:

Typical values; V_{CE} = 28 V; P_L = 80 W; T_h = 25 °C; class-B operation.

OPERATING NOTE for Figs 12, 13 and 14:

Below 50 MHz a base-emitter resistor of 4,7 Ω is recommended to avoid oscillation. This resistor must be effective for r.f. only.